

AP30T10GM-HF-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)			
100	0.051 at V _{GS} = 10 V	6.8	9 nC			
100	0.069 at V _{GS} = 4.5 V	5.8	9110			

SO-8

Top View

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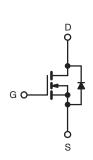
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- Halogen-free According to IEC 61249-2-21
 Available
- TrenchFET[®] Power MOSFET
- 100 % UIS Tested

APPLICATIONS

- High Frequency Boost Converter
- LED Backlight for LCD TV



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V _{DS}	100	V			
Gate-Source Voltage		V _{GS}	± 20	v		
	T _C = 25 °C		6.8			
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1_	5.4			
Continuous Drain Current $(1_j = 150^{\circ} C)$	T _A = 25 °C	- I _D	4.4 ^{a, b}			
	T _A = 70 °C		3.5 ^{a, b}	^		
Pulsed Drain Current		I _{DM}	20	A		
Continuous Courses Drain Diada Current	T _C = 25 °C	la la	5			
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	2.1 ^{a, b}			
Single Avalanche Current	L = 0.1 mH	I _{AS}	19			
Single Avalanche Energy	L = 0.1 mm	E _{AS}	18	mJ		
	T _C = 25 °C		6			
Maximum Power Dissinction	T _C = 70 °C	PD	3.8	w		
Maximum Power Dissipation	T _A = 25 °C	'D	2.5 ^{a, b}	vv		
	T _A = 70 °C		1.6 ^{a, b}			
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, c}	t ≤ 10 s	R _{thJA}	37	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	17	21	- 0/11		

Notes:

a. Surface Mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 85 °C/W.

d. $T_C = 25 \ ^{\circ}C.$

FREE

Available

SPECIFICATIONS $T_J = 25 \degree C$, Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Cymbol			Typ.	Max.		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$			120		- mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 9			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1	-	2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			_ ± 100	nA	
	-033	$V_{\rm DS} = 100 \text{ V}, \text{ V}_{\rm GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	20			A	
		V _{GS} = 10 V, I _D = 4.4 A		0.051			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.8 \text{ A}$		0.069		Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 4.4 \text{ A}$		10		S	
Dynamic ^b				1	I		
Input Capacitance	C _{iss}			600		pF	
Output Capacitance	C _{oss}	V_{DS} = 50 V, V_{GS} = 0 V, f = 1 MHz		90			
Reverse Transfer Capacitance	C _{rss}			50			
Tabal Oada Obarra	0	$V_{DS} = 50$ V, $V_{GS} = 10$ V, $I_{D} = 4.4$ A		13.5	20	nC	
Total Gate Charge	Qg			9	13.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 50$ V, $V_{GS} = 6$ V, $I_{D} = 4.4$ A		3			
Gate-Drain Charge	Q _{gd}			4.6			
Gate Resistance	Rg	f = 1 MHz		1		Ω	
Turn-On Delay Time	t _{d(on)}			15	25	-	
Rise Time	t _r	V_{DD} = 50 V, R_L = 14.3 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 3.5 A, V_GEN = 6 V, R_g = 1 Ω		12	20		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = 50 V, R_L = 14.3 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 3.5 A, V_GEN = 10 V, R_g = 1 Ω		15	25		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			5	A	
Pulse Diode Forward Current	I _{SM}				20	~	
Body Diode Voltage	V_{SD}	$I_{S} = 3.5 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			45	70	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 3.5 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		80	120	nC	
Reverse Recovery Fall Time	t _a	$r_{\rm F} = 0.0$ Å, u/u = 100 Å/µ3, $r_{\rm J} = 20$ 0		33		ns	
Reverse Recovery Rise Time	t _b			12			

a. Pulse test; pulse width \leq 300 μs , duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

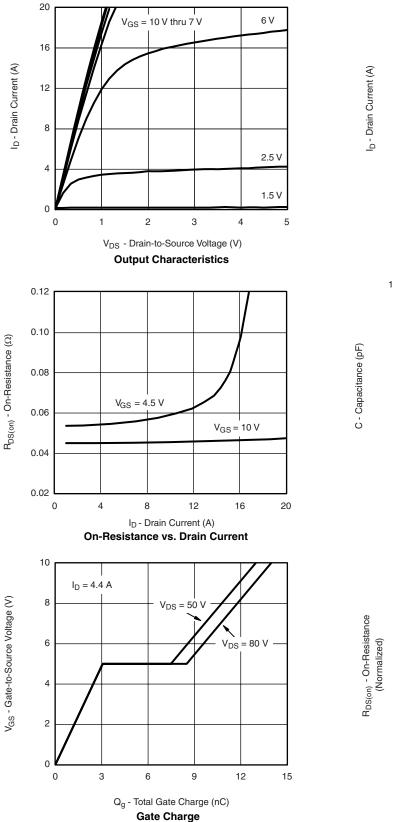
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

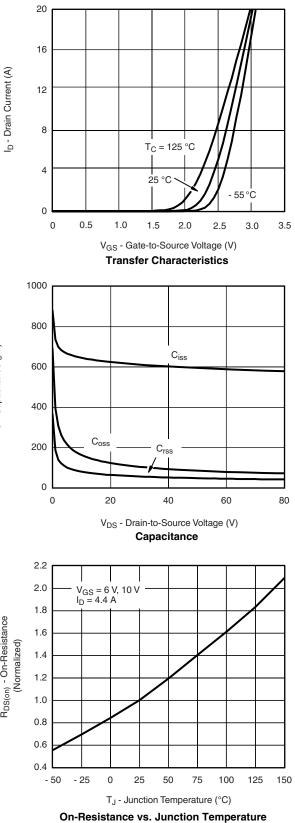
Bsemi

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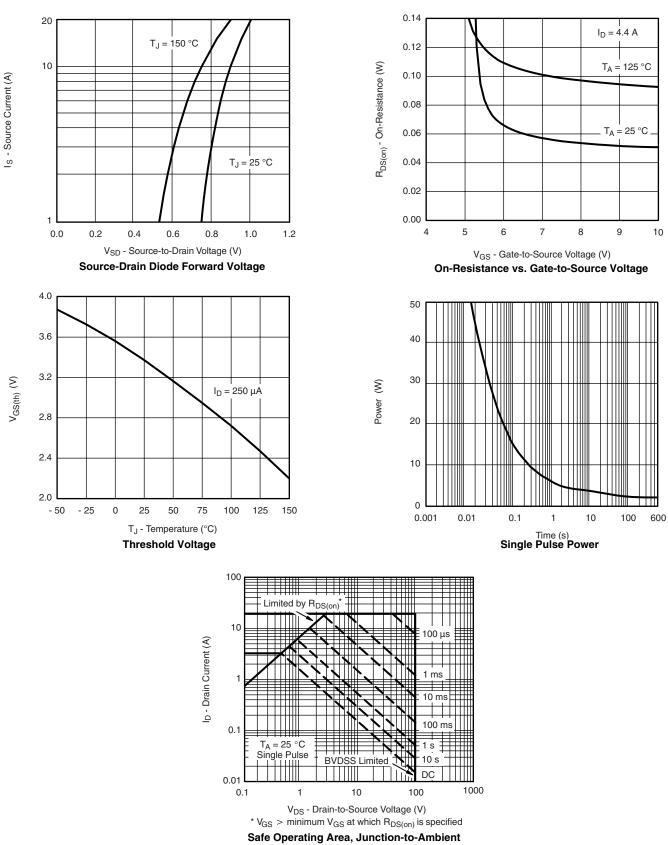
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







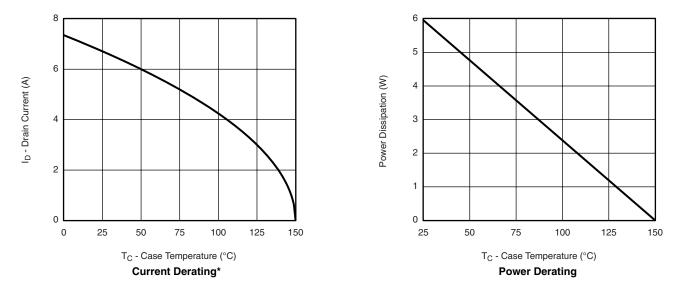
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

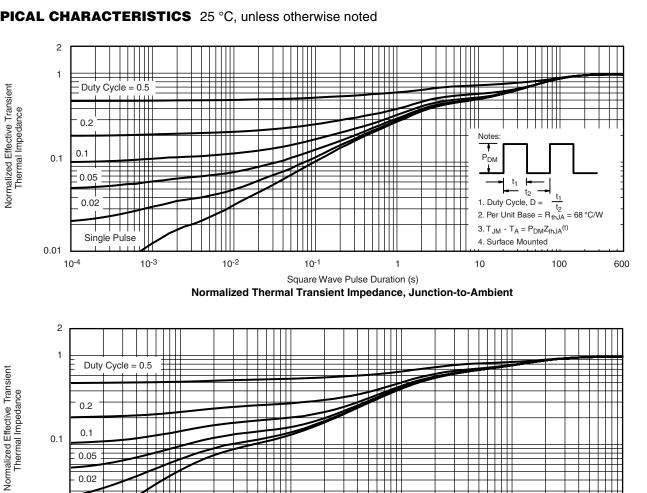
0.02

0.01

10⁻⁴

10^{- 3}

Single Pulse



10⁻²

Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Foot

10⁻¹

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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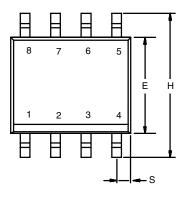
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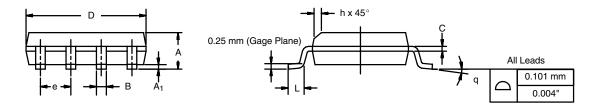
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012



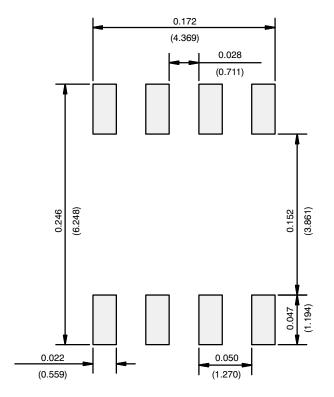


	MILLIM	IETERS	INCHES		
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					

AP30T10GM-HF-VB



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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